Notice of References Cited Application/Control No. 10/057,026 Examiner Ly T. TRAN Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,387,314	02-1995	Baughman et al.	216/27
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